

FCC TEST REPORT
for
PRADOTEC CORPORATION SDN. BHD. (807780-P)

Bluetooth Biometric Contactless Card Reader
Model No.: BCR250BT

Prepared for : PRADOTEC CORPORATION SDN. BHD. (807780-P)
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Report Number : R011412109E
Date of Test : Dec. 15, 2014~ Jan. 19, 2015
Date of Report : Jan. 19, 2015

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TEST REPORT VERIFICATION

Applicant : PRADOTEC CORPORATION SDN. BHD. (807780-P)
Manufacturer : OPTIMA KLASIK SDN. BHD. (807783-T)
EUT : Bluetooth Biometric Contactless Card Reader
Model No. : BCR250BT
Rating : DC 5V, 1A Via Adapter (AC 100-240V, 50/60Hz, 0.2A) /
DC 5V Via USB Port
Trade Mark : 

Measurement Procedure Used:

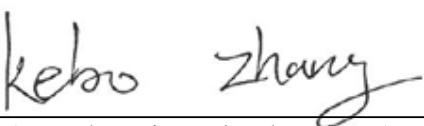
FCC Rules and Regulations Part 15 Subpart C 15.225 & FCC / ANSI C63.4-2009

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited To determine the maximum emission levels emanating from the device. The maximum emission levels are compared to the FCC Part 15 Subpart C limits both radiated and conducted emissions. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited Is assumed full responsibility for the accuracy and completeness of these measurements. Also, this report shows that the Equipment Under Test (EUT) is to be technically compliant with the FCC requirements.

This report applies to above tested sample only. This report shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test : Dec. 15, 2014~ Jan. 19, 2015

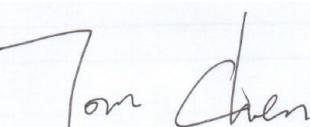
Prepared by :


(Tested Engineer / Kebo Zhang)

Reviewer :


(Project Manager / Amy Ding)

Approved & Authorized Signer :


(Manager / Tom Chen)

1. GENERAL INFORMATION

1.1. Description of Device (EUT)

Description	: Bluetooth Biometric Contactless Card Reader
Model Number	: BCR250BT
Test Power Supply	: AC 120V, 60Hz for adapter/ DC 5V Via USB Port/ DC 5V(With DC 3.7V Battery inside)
Adapter	: Model: AC/DC Adapter Input: AC 100-240V, 50/60Hz, 0.2A Output: DC 5V, 1A
Frequency	: 13.56 MHz
Antenna Gain	: 0 dBi
Antenna Type	: Integrated
Applicant Address	: PRADOTEC CORPORATION SDN. BHD. (807780-P) : IRIS Smart Technology Complex, Technology Park Malaysia, Bukit Jalil, 57000 Kuala Lumpur, Malaysia
Manufacturer Address	: OPTIMA KLASIK SDN. BHD. (807783-T) : IRIS Smart Technology Complex, Technology Park Malaysia, Bukit Jalil, 57000 Kuala Lumpur, Malaysia
Factory Address	: OPTIMA KLASIK SDN. BHD. (807783-T) : IRIS Smart Technology Complex, Technology Park Malaysia, Bukit Jalil, 57000 Kuala Lumpur, Malaysia
Date of Sample received	: Dec. 15, 2014
Date of Test	: Dec. 15, 2014~ Jan. 19, 2015

1.2. Auxiliary Equipment Used during Test

PC : Manufacturer: DELL
M/N: OPTIPLEX 380
S/N: 1J63X2X
CE , FCC: DOC

MONITOR : Manufacturer: DELL
M/N: E170Sc
S/N: CN-00V539-64180-055-0UPS
CE , FCC: DOC

KEYBOARD : Manufacturer: DELL
M/N: SK-8115
S/N: CN-0DJ313-71616-06C-02XN
CE , FCC: DOC
Cable: 1m, unshielded

MOUSE : Manufacturer: DELL
M/N: M-UARDEL7
S/N: N/A
CE , FCC: DOC
Cable: 1m, unshielded

Printer : Manufacturer:Brother
M/N: MFC-3360C
S/N: N/A
CE, FCC:DOC

Power Line : Non-Shielded, 1.5m

VGA Cable : Non-Shielded, 1.5m

1.3. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS - LAB Code: L3503

Shenzhen Anbotek Compliance Laboratory Limited., Laboratory has been assessed and in compliance with CNAS/CL01: 2006 accreditation criteria for testing laboratories (identical to ISO/IEC 17025:2005 General Requirements) for the Competence of Testing Laboratories.

FCC-Registration No.: 752021

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 752021, July 10, 2013.

IC-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited., EMC Laboratory has been registered and fully described in a report filed with the (IC) Industry Canada. The acceptance letter from the IC is maintained in our files. Registration 8058A-1, February 22, 2013.

Test Location

All Emissions tests were performed

Shenzhen Anbotek Compliance Laboratory Limited. at 1/F., Building 1, SEC Industrial Park, No.0409 Qianhai Road, Nanshan District, Shenzhen, Guangdong, China

1.4. Measurement Uncertainty

Radiation Uncertainty : Ur = 4.3dB

Conduction Uncertainty : Uc = 3.4dB

2. Test Procedure

GENERAL: This report shall NOT be reproduced except in full without the written approval of Shenzhen Anbotek Compliance Laboratory Limited. The EUT was transmitting a test signal during the testing.

RADIATION INTERFERENCE: The test procedure used was ANSI STANDARD C63.4-2009 using a spectrum analyzer with a pre-selector. The analyzer was calibrated in dB above a microvolt at the output of the antenna. The resolution bandwidth was 100KHz and the video bandwidth was 300KHz up to 1.0GHz and 1.0MHz with a video BW of 3.0MHz above 1.0GHz. The ambient temperature of the EUT was 74.3oF with a humidity of 69%.

FORMULA OF CONVERSION FACTORS: The Field Strength at 3m was established by adding the meter reading of the spectrum analyzer (which is set to read in units of dBuV) to the antenna correction factor supplied by the antenna manufacturer. The antenna correction factors are stated in terms of dB. The gain of the Preselector was accounted for in the Spectrum Analyzer Meter Reading.

Example:

Freq (MHz) METER READING + ACF = FS
33 20 dBuV + 10.36 dB = 30.36 dBuV/m @ 3m

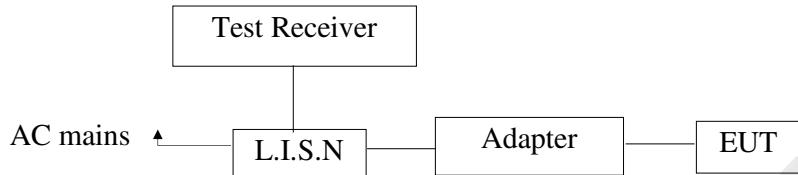
ANSI STANDARD C63.4-2009 10.1.7 MEASUREMENT PROCEDURES: The EUT was placed on a table 80 cm high and with dimensions of 1m by 1.5m. The EUT was placed in the center of the table (1.5m side). The table used for radiated measurements is capable of continuous rotation.

When an emission was found, the table was rotated to produce the maximum signal strength. At this point, the antenna was raised and lowered from 1m to 4m. The antenna was placed in both the horizontal and vertical planes.

3. POWER LINE CONDUCTED measurement

3.1 Block Diagram of Test Setup

3.1.1. Block diagram of connection between the EUT and simulators



3.2 Power Line Conducted Emission Measurement Limits (15.207)

Frequency MHz	Limits dB(μ V)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*
0.50 ~ 5.00	56	46
5.00 ~ 30.00	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.
2. The lower limit shall apply at the transition frequencies.

3.3 Configuration of EUT on Measurement

The following equipments are installed on Power Line Conducted Emission Measurement to meet the commission requirement and operating regulations in a manner which tends to maximize its emission characteristics in a normal application.

3.4 Operating Condition of EUT

- 3.4.1. Setup the EUT and simulator as shown as Section 3.1.
- 3.4.2. Turn on the power of all equipment.
- 3.4.3. Let the EUT work in test mode (Charging to adapter) and measure it.

3.5 Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.4-2003 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9KHz.

The frequency range from 150KHz to 30MHz is checked.

The test results are reported on Section 3.6.

3.6 Test equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Two-Line V-network	Rohde & Schwarz	ENV216	100055	Apr. 22, 2014	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Apr. 22, 2014	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Apr. 22, 2014	1 Year

3.7 Power Line Conducted Emission Measurement Results

PASS.

The frequency range from 150KHz to 30 MHz is investigated.

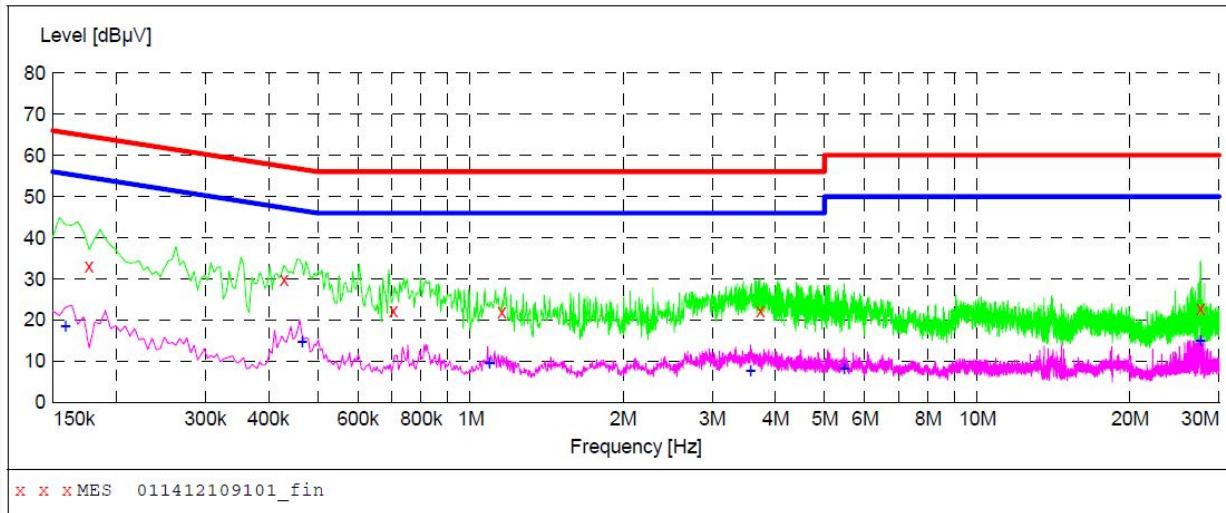
Please refer the following pages.

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
 Operating Condition: Charging to adapter
 Test Specification: AC 120V, 60Hz for adapter
 Comment: Live Line
 Tem.:25°C Hum:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



MEASUREMENT RESULT: "011412109101_fin"

12/15/2014 9:55AM

Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.177000	33.00	20.1	65	31.6	QP	L1	GND
0.429000	29.80	20.1	57	27.5	QP	L1	GND
0.703500	22.30	20.1	56	33.7	QP	L1	GND
1.153000	22.10	20.2	56	33.9	QP	L1	GND
3.736000	22.40	20.4	56	33.6	QP	L1	GND
27.572500	22.90	20.9	60	37.1	QP	L1	GND

MEASUREMENT RESULT: "011412109101_fin2"

12/15/2014 9:55AM

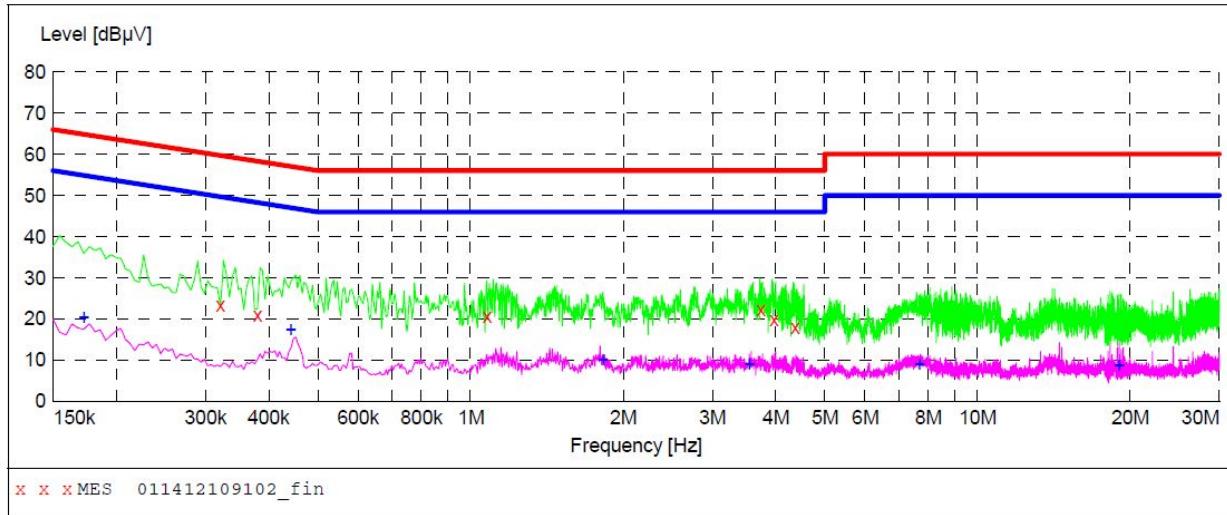
Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.159000	18.40	20.1	56	37.1	AV	L1	GND
0.465000	14.70	20.1	47	31.9	AV	L1	GND
1.090000	9.60	20.2	46	36.4	AV	L1	GND
3.574000	7.70	20.4	46	38.3	AV	L1	GND
5.455000	8.30	20.5	50	41.7	AV	L1	GND
27.572500	15.10	20.9	50	34.9	AV	L1	GND

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
 Operating Condition: Charging to adapter
 Test Specification: AC 120V, 60Hz for adapter
 Comment: Neutral Line
 Tem.:25°C Hum:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



MEASUREMENT RESULT: "011412109102_fin"

12/15/2014 9:58AM

Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.321000	23.40	20.1	60	36.3	QP	N	GND
0.379500	21.10	20.1	58	37.2	QP	N	GND
1.076500	20.60	20.2	56	35.4	QP	N	GND
3.740500	22.20	20.4	56	33.8	QP	N	GND
3.965500	19.90	20.4	56	36.1	QP	N	GND
4.366000	18.10	20.5	56	37.9	QP	N	GND

MEASUREMENT RESULT: "011412109102_fin2"

12/15/2014 9:58AM

Frequency MHz	Level dB μ V	Transd dB	Limit dB μ V	Margin dB	Detector	Line	PE
0.172500	20.30	20.1	55	34.5	AV	N	GND
0.442500	17.50	20.1	47	29.5	AV	N	GND
1.823500	10.10	20.3	46	35.9	AV	N	GND
3.547000	9.10	20.4	46	36.9	AV	N	GND
7.678000	9.10	20.5	50	40.9	AV	N	GND
19.036000	8.90	20.8	50	41.1	AV	N	GND

4. RADIATED EMISSION MEASUREMENT

4.1. Radiated Emission Limits

- (a) The field strength of any emissions within the band 13.553–13.567 MHz shall not exceed 15,848 microvolts/meter at 30 meters.
- (b) Within the bands 13.410–13.553 MHz and 13.567–13.710 MHz, the field strength of any emissions shall not exceed 334 microvolts/meter at 30 meters.
- (c) Within the bands 13.110–13.410 MHz and 13.710–14.010 MHz the field strength of any emissions shall not exceed 106 microvolts/meter at 30 meters.
- (d) The field strength of any emissions appearing outside of the 13.110–14.010 MHz band shall not exceed the general radiated emission limits in §15.209.

Note:

- (1) The tighter limit shall apply at the boundary between two frequency range.
- (2) Limitation expressed in dBuV/m is calculated by $20\log$ Emission Level (uV/m).
- (3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $Ld1 = Ld2 * (d2/d1)^2$.

Example:

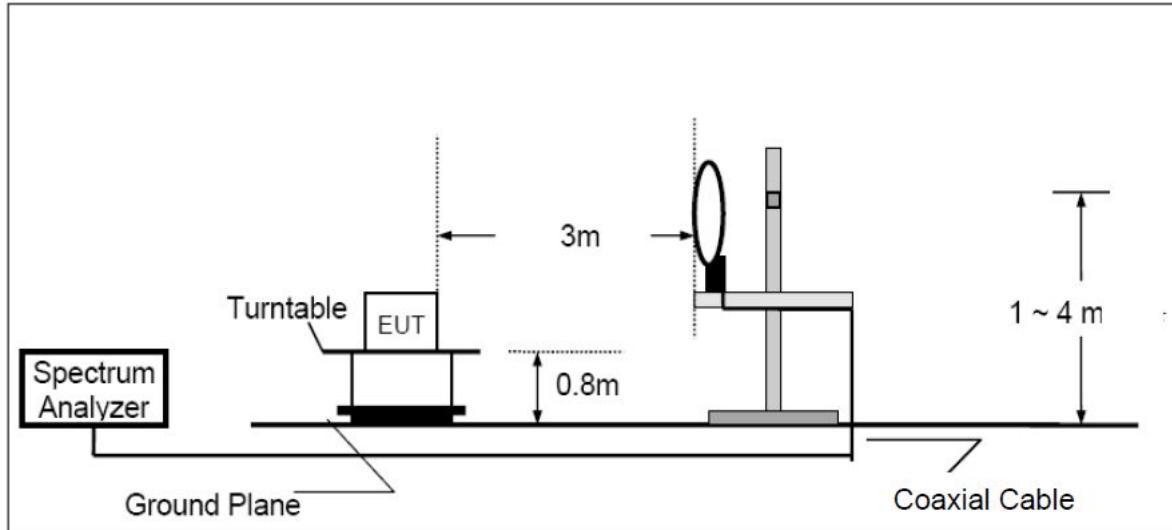
F.S Limit at 30m distance is 30uV/m , then F.S Limitation at 3m distance is adjusted as $Ld1 = L1 = 30uV/m * (10)^2 = 100 * 30 uV/m$

4.2. Test Procedure

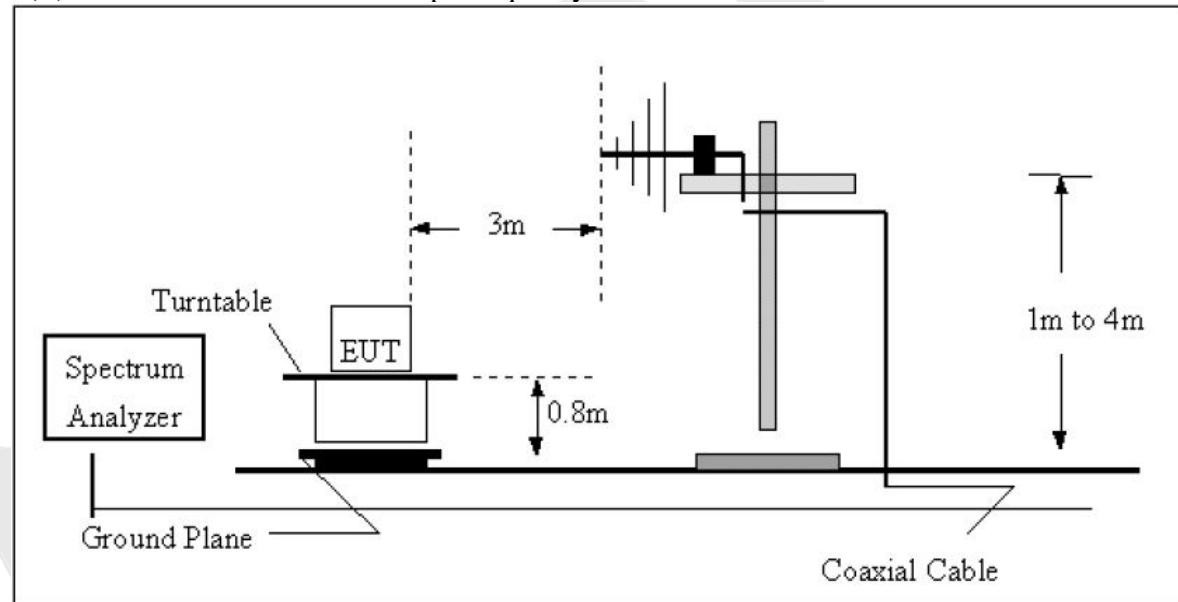
- a. The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

4.3. Test Setup

(A) Radiated Emission Test Set-Up, Frequency below 30MHz



(B) Radiated Emission Test Set-Up, Frequency 30-1000MHz



Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analysis	Agilent	E4407B	US39390582	Aug. 08, 2014	1 Year
2.	Preamplifier	Instruments corporation	EMC011830	980100	Aug. 08, 2014	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESPI	101604	Apr. 22, 2014	1 Year
4.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Apr. 04, 2014	1 Year
5.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Apr. 24, 2014	1 Year
6.	Pre-amplifier	SONOMA	310N	186860	Aug. 08, 2014	1 Year
7.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A

4.4. Test Results (Field Strength within the band of operation)

Freq.(MHz)	Ant. Orientation	Result at 3m (dBuV/m)	Limitation Converted 3m dist. (dBuV/m)	Margin dB
13.110	Front	59.15	80.50	-21.35
13.410	Front	63.72	80.50	-16.78
13.553	Front	74.51	90.50	-15.99
13.560	Front	86.03	124.00	-37.97
13.567	Front	64.15	90.50	-26.35
13.710	Front	63.67	80.50	-16.83
14.010	Front	59.07	80.50	-21.43
--	--	--	--	--
13.110	Side	58.61	80.50	-21.89
13.410	Side	64.25	80.50	-16.25
13.553	Side	74.93	90.50	-15.57
13.560	Side	85.77	124.00	-38.23
13.567	Side	67.25	90.50	-23.25
13.710	Side	62.44	80.50	-18.06
14.010	Side	57.03	80.50	-23.47
--	--	--	--	--

Remark:

- (1) Spectrum Setting:
150 K Hz – 30 MHz, RBW= 9 KHz, VBW=9 KHz, Sweep time = 200 ms.
- (2) The Log-Bicon Antenna will use to test frequency range from 30MHz to 1000MHz and the Loop Antenna will use to test frequency below 30MHz.
- (3) If the peak scan value lower limit more than 20dB, then this signal data does not show in table.

4.5. Test Results (Field strength outside of the band of operation)

PASS.

Please refer the following pages.

Job No.:	011412109E	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C _3m	Power Source:	AC 120V, 60Hz for adapter
Test item:	Radiation Test (30~1000MHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	Charging to adapter	Distance:	3m

80.0 dBuV/m

40

0.0

1 2 3 4 5 6

30.000 40 50 60 70 80 90 100 110 120 130 140 150 160 170 180 190 200 210 220 230 240 250 260 270 280 290 300 310 320 330 340 350 360 370 380 390 400 410 420 430 440 450 460 470 480 490 500 510 520 530 540 550 560 570 580 590 600 610 620 630 640 650 660 670 680 690 700 710 720 730 740 750 760 770 780 790 800 810 820 830 840 850 860 870 880 890 900 910 920 930 940 950 960 970 980 990 1000.000

No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	32.2925	39.48	-15.73	23.75	40.00	-16.25	peak			
2	41.1320	32.45	-10.81	21.64	40.00	-18.36	peak			
3	112.1305	42.16	-20.77	21.39	43.50	-22.11	peak			
4	364.2595	47.89	-13.58	34.31	46.00	-11.69	peak			
5	386.6338	47.25	-13.14	34.11	46.00	-11.89	peak			
6	446.4141	43.46	-12.17	31.29	46.00	-14.71	peak			

Job No.:	011412109E	Polarization:	Vertical
Standard:	(RE)FCC PART 15C _3m	Power Source:	AC 120V, 60Hz for adapter
Test item:	Radiation Test (30~1000MHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	Charging to adapter	Distance:	3m

80.0 dBuV/m

40

0.0

30.000 40 50 60 70 80 [MHz] 300 400 500 600 700 1000.000

Limit: — Red
Margin: — Green

No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	51.4807	43.29	-14.68	28.61	40.00	-11.39	peak			
2	119.8556	48.62	-16.32	32.30	43.50	-11.20	peak			
3	303.5437	46.46	-14.61	31.85	46.00	-14.15	peak			
4	386.6338	44.85	-12.14	32.71	46.00	-13.29	peak			
5	552.8832	44.06	-10.04	34.02	46.00	-11.98	peak			
6	649.6597	40.32	-8.85	31.47	46.00	-14.53	peak			